Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/758,749	LEASON, DAVID
Examiner	Art Unit
Pablo N. Tran	2618

	SEARCHED		
Class	Subclass	Date	Examiner
455	qv.2	07/18/06	J.
	90.3		7
	99-100	0	
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	94 569.1 569.2		
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INTERFERENCE SEARCHED			ED
Class	Subclass	Date	Examiner
455	95-96	07/15/06	2
	345-34	6	
	802		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE EXM				
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Search	Notes	(continued))

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/758,749	LEASON, DAVID	
Examiner	Art Unit	
Pablo N. Tran	2618	

	SEARC	HED	
Class	Subclass	Date	Examiner
458		ण्डीविक	.7
	343.3		1
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	348-349		
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	152.1		
	902		
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340	311.2		

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